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# MOSFET - N-Channel, Silicon Carbide 1200 V, 40 mΩ

# **NVC040N120SC1**

### **Description**

Silicon Carbide (SiC) MOSFET uses a completely new technology that provide superior switching performance and higher reliability compared to Silicon. In addition, the low ON resistance and compact chip size ensure low capacitance and gate charge. Consequently, system benefits include highest efficiency, faster operation frequency, increased power density, reduced EMI, and reduced system size.

#### **Features**

- $1200 \text{ V} @ \text{T}_{\text{J}} = 175^{\circ}\text{C}$
- Typ  $R_{DS(on)} = 40 \text{ m}\Omega$  at  $V_{GS} = 20 \text{ V}$ ,  $I_D = 40 \text{ A}$
- High Speed Switching with Low Capacitance
- 100% UIL Tested
- Qualified According to AEC-Q101 Conditions
- These Devices are Pb-Free and are RoHS Compliant

### **Applications**

- Automotive Traction Inverter
- Automotive DC/DC Converter for EV/HEV

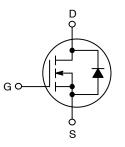


### ON Semiconductor®

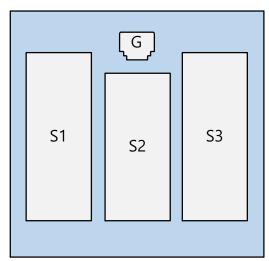
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V <sub>(BR)DSS</sub>	R <sub>DS(on)</sub> MAX	I <sub>D</sub> MAX
1200 V	56 m $\Omega$ @ 20 V	60 A

#### **N-CHANNEL MOSFET**



#### **DIE DIAGRAM**



#### **Die Information**

Wafer Diameter 6 inch

• Die Size 4,270 x 3,560 μm

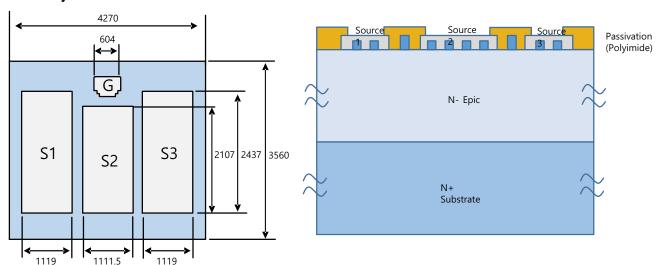
Metallization

· Top Ti/TiN/Al 5 μm · Back Ti/NiV/Ag

Die Thickness Typ. 200 μm
 Gate Pad Size 604 x 415 μm

### **Die Layout**

### **Die Cross Section**



### **Passivation Information**

- Passivation Material: Polymide (PSPI)
- Passivation Type: Local Passivation
- Passivation Thickness 10  $\mu m$ 
  - : Passivation Area

### **Die Layout**

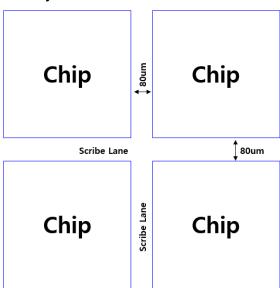


Figure 1. Bare Die Dimensions

### **MAXIMUM RATINGS** (T<sub>C</sub> = 25°C unless otherwise noted)

Parame	Symbol	Value	Unit		
Drain-to-Source Voltage			V <sub>DSS</sub>	1200	V
Gate-to-Source Voltage			V <sub>GS</sub>	-15/+25	V
Recommended Operation Values of Gate-to-Source Voltage	T <sub>C</sub> < 175°C		$V_{GSop}$	-5/+20	V
Continuous Drain Current $R_{\theta JC}$	Steady State	T <sub>C</sub> = 25°C	I <sub>D</sub>	60	Α
Power Dissipation $R_{\theta JC}$			P <sub>D</sub>	348	W
Continuous Drain Current $R_{\theta JC}$	Steady State	T <sub>C</sub> = 100°C	I <sub>D</sub>	42	Α
Power Dissipation $R_{\theta JC}$			P <sub>D</sub>	174	W
Pulsed Drain Current (Note 2)	Т	<sub>C</sub> = 25°C	I <sub>DM</sub>	240	Α
Single Pulse Surge Drain Current Capability	T <sub>C</sub> = 25°C, t <sub>p</sub>	$_{0}$ = 10 μs, $R_{G}$ = 4.7 $\Omega$	I <sub>DSC</sub>	416	Α
Operating Junction and Storage Temperature Range			T <sub>J</sub> , T <sub>stg</sub>	-55 to +175	°C
Source Current (Body Diode)			Is	34	Α
Single Pulse Drain-to-Source Avalanche Energy ( $I_{L(pk)}$ = 35 A, L = 1 mH) (Note 3)			E <sub>AS</sub>	613	mJ

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

### THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case (Note 1)	$R_{ hetaJC}$	0.43	°C/W

<sup>1.</sup> The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.

<sup>2.</sup> Repetitive rating, limited by max junction temperature. 3.  $E_{AS}$  of 613 mJ is based on starting  $T_J = 25^{\circ}C$ ; L = 1 mH,  $I_{AS} = 35$  A,  $V_{DD} = 120$  V,  $V_{GS} = 20$  V.

### **ELECTRICAL CHARACTERISTICS** (T<sub>J</sub> = 25°C unless otherwise noted)

Parameter	Symbol	Test Conditions	Min	Тур	Max	Unit
OFF CHARACTERISTICS	•			•		•
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	V <sub>GS</sub> = 0 V, I <sub>D</sub> = 1 mA	1200	_	-	V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V <sub>(BR)DSS</sub> /T <sub>J</sub>	I <sub>D</sub> = 1 mA, referenced to 25°C	-	450	-	mV/°C
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>GS</sub> = 0 V, V <sub>DS</sub> = 1200 V, T <sub>J</sub> = 25°C	-	-	100	μΑ
		V <sub>GS</sub> = 0 V, V <sub>DS</sub> = 1200 V, T <sub>J</sub> = 175°C	_	-	250	
Gate-to-Source Leakage Current	I <sub>GSS</sub>	$V_{GS} = +25/-15 \text{ V}, V_{DS} = 0 \text{ V}$	-	-	±1	μΑ
ON CHARACTERISTICS						
Gate Threshold Voltage	V <sub>GS(th)</sub>	$V_{GS} = V_{DS}$ , $I_D = 10 \text{ mA}$	1.8	2.97	4.3	V
Recommended Gate Voltage	V <sub>GOP</sub>		-5	_	+20	V
Drain-to-Source On Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 20 V, I <sub>D</sub> = 35 A, T <sub>J</sub> = 25°C	_	39	56	mΩ
		V <sub>GS</sub> = 20 V, I <sub>D</sub> = 35 A, T <sub>J</sub> = 150°C	-	60	-	
Forward Transconductance	9FS	V <sub>DS</sub> = 20 V, I <sub>D</sub> = 35 A	-	20	-	S
CHARGES, CAPACITANCES & GATE	RESISTANCE					
Input Capacitance	C <sub>ISS</sub>	V <sub>GS</sub> = 0 V, f = 1 MHz, V <sub>DS</sub> = 800 V	-	1781	_	pF
Output Capacitance	C <sub>OSS</sub>		-	140	-	
Reverse Transfer Capacitance	C <sub>RSS</sub>	]	-	12	-	
Total Gate Charge	Q <sub>G(tot)</sub>	$V_{GS} = -5/20 \text{ V}, V_{DS} = 600 \text{ V}, I_D = 47 \text{ A}$	-	106	-	nC
Threshold Gate Charge	Q <sub>G(th)</sub>	]	_	16	-	
Gate-to-Source Charge	Q <sub>GS</sub>	]	-	34	-	
Gate-to-Drain Charge	Q <sub>GD</sub>	]	_	26	-	
Gate Resistance	R <sub>G</sub>	f = 1 MHz	_	2.2	-	Ω
SWITCHING CHARACTERISTICS				•		•
Turn-On Delay Time	t <sub>d(on)</sub>	$V_{GS} = -5/20 \text{ V}, V_{DS} = 800 \text{ V},$	_	18	-	ns
Rise Time	t <sub>r</sub>	$I_D = 47 \text{ A}, R_G = 4.7 \Omega,$ Inductive Load	_	41	_	
Turn-Off Delay Time	t <sub>d(off)</sub>	]	_	33	_	
Fall Time	t <sub>f</sub>	]	_	10.4	_	
Turn-On Switching Loss	E <sub>ON</sub>	]	_	1003	_	μJ
Turn-Off Switching Loss	E <sub>OFF</sub>	]	_	247	_	
Total Switching Loss	E <sub>TOT</sub>	]	_	1248	_	
DRAIN-SOURCE DIODE CHARACTER	RISTICS				l	l
Continuous Drain-to-Source Diode Forward Current	I <sub>SD</sub>	V <sub>GS</sub> = -5 V	-	_	34	Α
Pulsed Drain-to-Source Diode Forward Current (Note 2)	I <sub>SDM</sub>	V <sub>GS</sub> = -5 V	_	-	240	Α
Forward Diode Voltage	$V_{SD}$	V <sub>GS</sub> = -5 V, I <sub>SD</sub> = 17.5 A	_	3.8	-	V
Reverse Recovery Time	t <sub>RR</sub>	$V_{GS} = -5/20 \text{ V}, I_{SD} = 47 \text{ A},$	-	24	-	ns
Reverse Recovery Charge	Q <sub>RR</sub>	dl <sub>S</sub> /dt = 1000 A/μs	-	125	-	nC
Reverse Recovery Energy	E <sub>REC</sub>	]	_	8.5	-	μJ
Peak Reverse Recovery Current	I <sub>RRM</sub>	1	-	10.4	-	Α
Charge Time	ta	1	-	12.4	-	ns
Discharge Time	t <sub>b</sub>	1	-	11.6	-	ns
	1			l	l	l

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

### **TYPICAL CHARACTERISTICS** (T<sub>J</sub> = 25°C unless otherwise noted)

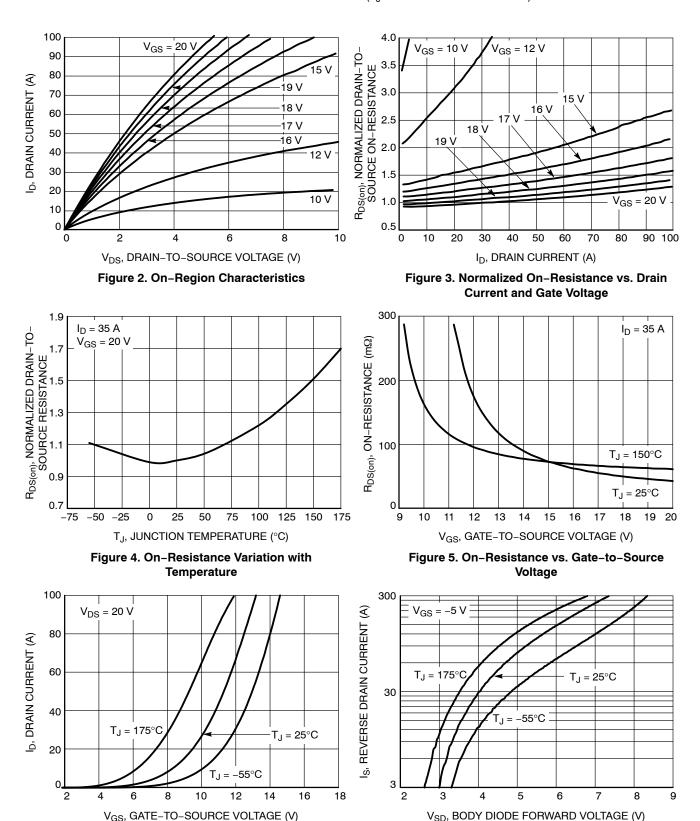


Figure 7. Diode Forward Voltage vs. Current

Figure 6. Transfer Characteristics

### TYPICAL CHARACTERISTICS (T<sub>J</sub> = 25°C unless otherwise noted)

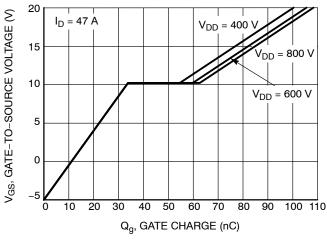


Figure 8. Gate-to-Source Voltage vs. Total Charge

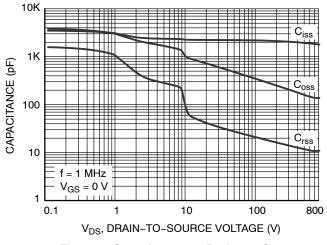


Figure 9. Capacitance vs. Drain-to-Source Voltage

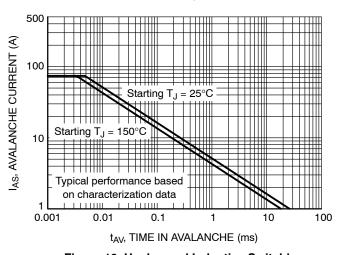


Figure 10. Unclamped Inductive Switching Capability

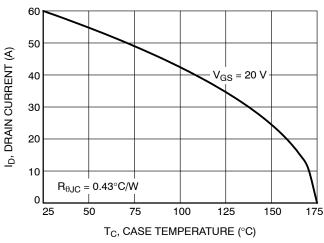


Figure 11. Maximum Continuous Drain Current vs. Case Temperature

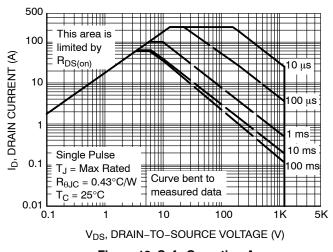


Figure 12. Safe Operating Area

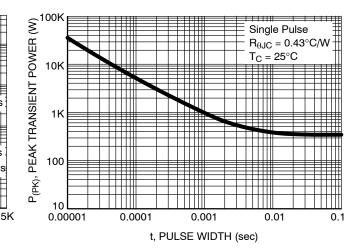


Figure 13. Single Pulse Maximum Power Dissipation

### TYPICAL CHARACTERISTICS (T. = 25°C unless otherwise noted)

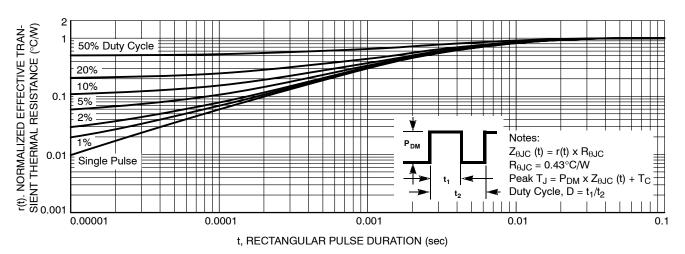


Figure 14. Junction-to-Ambient Thermal Response

#### ORDERING INFORMATION AND PACKAGE MARKING

Orderable Part Number	Top Marking	Package	Packing Method	Reel Size	Tape Width	Quantity
NVC040N120SC1	No Marking	Die	Wafer	N/A	N/A	N/A

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